



# Ab Initio Mechanical Properties of Alumina Polymorphs for Cold Spray Al Powder Passivation Layers

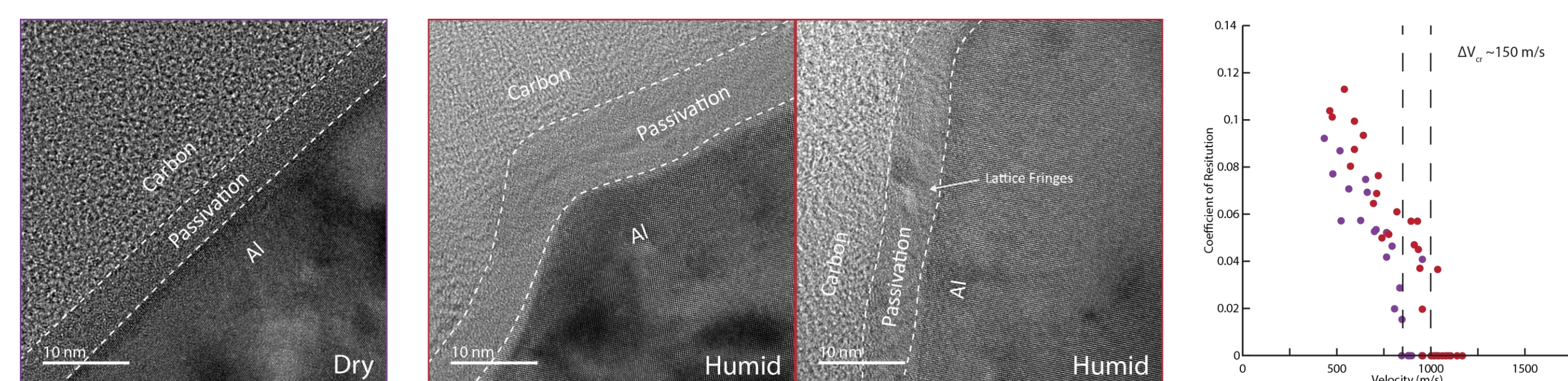
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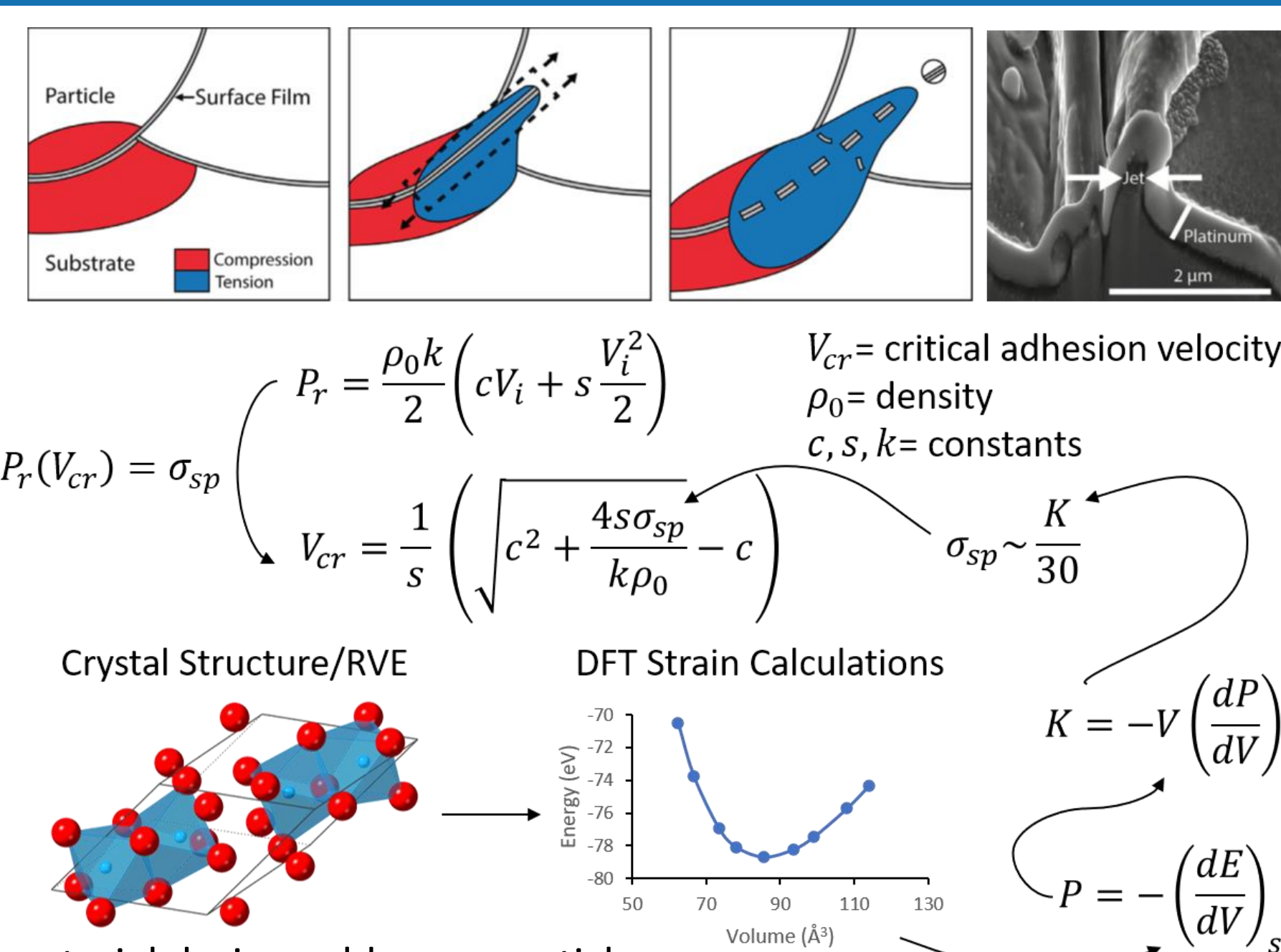
## Introduction

- Cold spray of aluminum powder is heavily influenced by particle passivation layers which must fracture for metallic bonding to occur.
- Previous work<sup>1</sup> identified powder particles treated under humid conditions had thicker passivation layers and the presence of hydration and partial crystallinity contributing to an increase in critical adhesion velocity ( $V_{cr}$ ) of approximately 150 m/s.
- It remains unclear whether crystallinity, thickness, composition or some combination are principally responsible.
- Experimental characterization of several nanometer thick passivation layers is prohibitively complex.
- Here, a first principles approach permits calculation of the mechanical properties for the majority of alumina polymorphs including oxide, hydrated, crystalline, and amorphous phases.

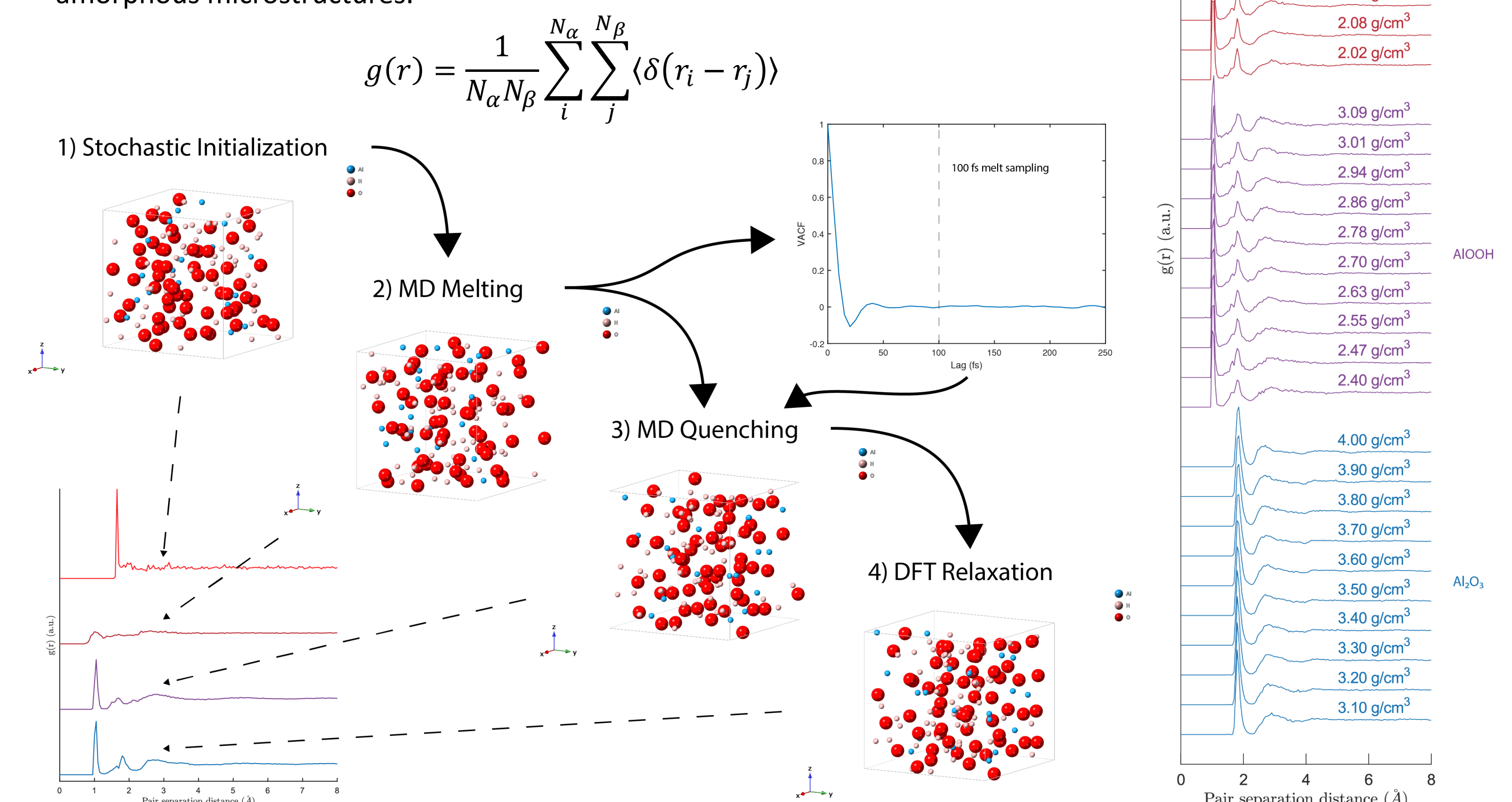


## Computational Approach

- First principles static relaxation of polymorph structures is performed using Vienna Ab-Initio Simulation Package (VASP)<sup>2</sup> using the PBE functional<sup>3</sup>.
- Crystalline phases, following initial relaxation, are homogeneously strained and relaxed under constant volume and cell shape to obtain their energy-volume relation.
- Bulk moduli are determined by fitting the Murnaghan equation of state<sup>4</sup>. For amorphous structures, this is done using the average of 20 simulations at 10 separate volumes.



- Assuming high strain rates typical of the jetted material during cold spray particle impingement, the spall strength ( $\sigma_{sp}$ ) is proportional to the bulk modulus ( $K$ ) allowing estimation of the critical adhesion velocity using shock<sup>5</sup>.
- Amorphous microstructures are generated using molecular dynamics via a melting (6000° K, sampling every 100 fs after equilibrium is reached) and quenching (6000 - 300° K, -1.5 K/fs) scheme with a ReaxFF potential<sup>6</sup> incorporating aluminum ions in LAMMPS<sup>7</sup> followed by static relaxations using VASP.
- The radial distribution function,  $g(r)$ , is used to confirm the simulations produce amorphous microstructures.



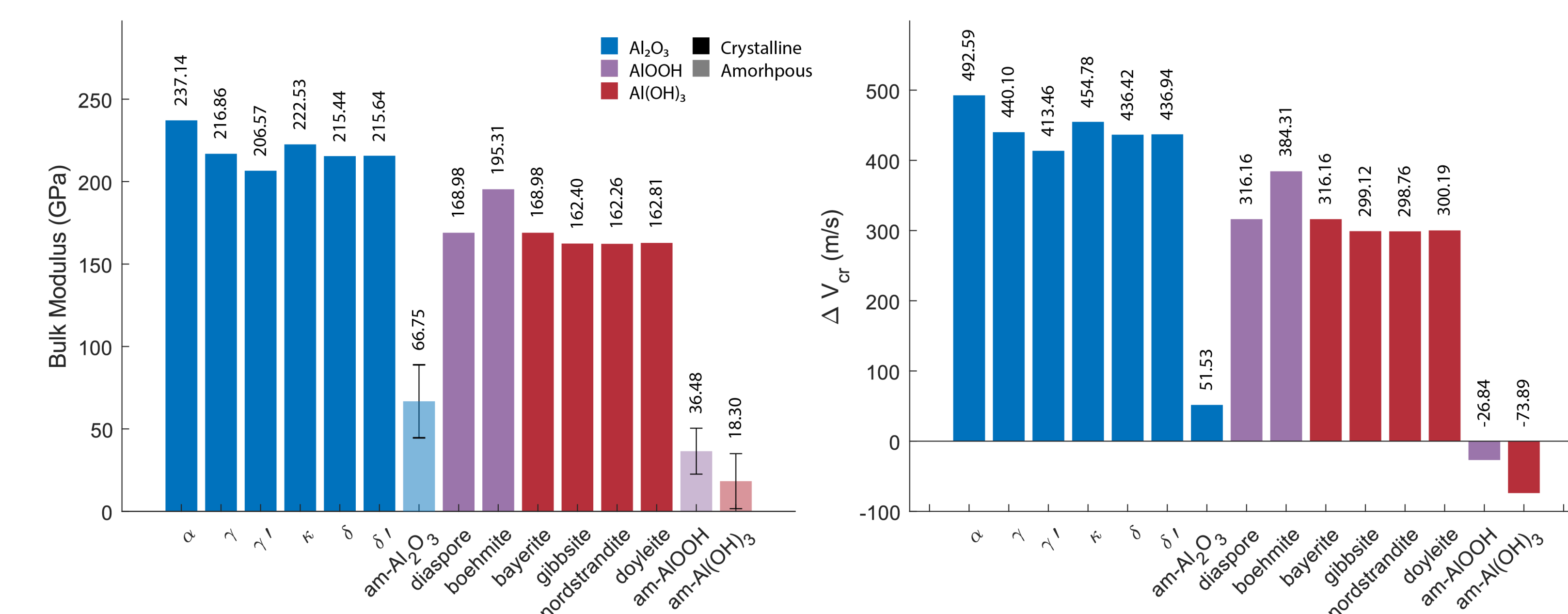
## Results

- Bulk modulus is highest, as expected, for thermodynamically stable  $\alpha$ - $\text{Al}_2\text{O}_3$  and lowest for am- $\text{Al}(\text{OH})_3$ .
- The bulk moduli do not differ significantly within crystalline transition oxides or crystalline oxyhydroxides and hydroxides.
- The largest variations in bulk moduli are observed across crystalline and amorphous phases.
- Assuming the jetted material at the boundary of the particle-substrate interface is purely in tension and the observation that the jet is nominally 100 nm across, a simple rule-of-mixtures is used to approximate the spall strength of the interface and thus the critical adhesion velocity using the following values:  $\sigma_{Al} = 1.02 \text{ GPa}$ ,  $V_{cr,dry} = 850 \text{ m/s}$ ,  $f_{pass,humid} = 0.08$ , and  $f_{pass,dry} = 0.05$ .

$$V_{cr} \propto \sigma_{sp,jet} \propto \sigma_{Al}(1 - f_{pass}) + \frac{K_{pass}}{30} f_{pass} = \sigma_{Al}(1 - f_{pass}) + \sigma_{pass} f_{pass}$$

$$\Delta V_{cr} = V_{cr,dry} \left[ \frac{\sigma_{Al}(1 - f_{pass,humid}) + \frac{K_{pass}}{30} f_{pass,humid}}{\sigma_{Al}(1 - f_{am-Al_2O_3}) + \frac{K_{am-Al_2O_3}}{30} f_{am-Al_2O_3}} - 1 \right]$$

- Amorphous AlOOH and  $\text{Al}(\text{OH})_3$  result in a reduction in critical adhesion velocity despite a thicker passivation layer.
- Note that the formula above is very sensitive to thickness (i.e.  $f$ ). In this approximation, passivation layers are treated as uniform and smooth. However, thickness variations were previously observed in micrographs of the humidity treated passivation layer.
- A fully crystalline passivation layer regardless of composition would have a significantly higher critical adhesion velocity.



## Conclusions

- Given the lower bulk moduli of both amorphous and crystalline (oxy)hydroxides compared to the oxides, the critical adhesion velocity is expected to decrease and therefore does not explain the results of experiments.
- Rather, it seems hydration plays an integral role in the accelerated passivation layer growth at low temperatures.
- Likewise, the bulk moduli of crystalline oxides do not significantly differ. Though am- $\text{Al}_2\text{O}_3$  is thermodynamically stable below ~10 nm, above that  $\gamma$ - $\text{Al}_2\text{O}_3$  becomes more favorable<sup>8</sup>, meaning any crystallinity significantly increases  $V_{cr}$ .
- As previous micrographs show, the presence of partial crystallinity in passivation layers ~8-10 nm thick points to thickness and crystallinity being the principle drivers of increases in critical adhesion velocity.

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